

Notice of References Cited	Application/Control No. 10/590,417		Applicant(s)/Patent Under Reexamination YAMANASHI ET AL.	
	Examiner QI HAN		Art Unit 2626	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,898,566 B1	05-2005	Benyassine et al.	704/226
*	B	US-6,760,435 B1	07-2004	Etter et al.	379/406.01
*	C	US-6,125,179 A	09-2000	Wu, Ying	379/388.01
*	D	US-6,201,796 B1	03-2001	Agazzi et al.	370/286
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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